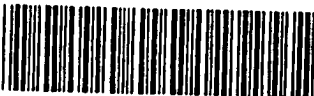


PA-IDC

QUERY CONTROL FORM		RTIS USE ONLY	
Application No. <u>09/ 540,288</u>	Prepared by <u>NPB</u>	Tracking Number <u>0588/958</u>	
Examiner-GAU <u>Patel - 2879</u>	Date <u>2/18/04</u>	Week Date <u>12/21/03</u>	
	No. of queries <u>3</u>	<u>IPW</u>	

JACKET			
a. Serial No.	f. Foreign Priority	k. Print Claim(s)	p. PTO-1449
b. Applicant(s)	g. Disclaimer	l. Print Fig.	q. PTOL-85b
c. Continuing Data	h. Microfiche Appendix	m. Searched Column	<u>r. Abstract</u>
d. PCT	i. Title	n. PTO-270/328	s. Sheets/Figs
e. Domestic Priority	j. Claims Allowed	o. PTO-892	t. Other

SPECIFICATION	MESSAGE
a. Page Missing	<p>① There are two(2) claim 72's in the index of claims and no claim 71. please advise.</p>
b. Text Continuity	
c. Holes through Data	
d. Other Missing Text	<p>② claim 126 (was original claim 316) depends on a high claim number 129 (original claim 310). please advise/correct claim dependency.</p>
e. Illegible Text	
f. Duplicate Text	
g. Brief Description	<p>③ Abstract is too long: Please shorten Abstract, in light of MPEP 608.01(b), paragraph entitled "Language and Format".</p>
h. Sequence Listing	
i. Appendix	
j. Amendments	<p>Thank you</p>
k. Other	
<p>initials <u>MPB</u></p>	
<p><b>CLAIMS</b></p>	
a. Claim(s) Missing	<p>RESPONSE</p>
b. Improper Dependency	
c. Duplicate Numbers	
d. Incorrect Numbering	
e. Index Disagrees	
f. Punctuation	
g. Amendments	
h. Bracketing	
i. Missing Text	
j. Duplicate Text	
k. Other	<p>initials</p>

<b>Issue Classification</b> 	Application No.	Applicant(s)	
	09/540,288	WU ET AL.	
	Examiner	Art Unit	
	Mariceli Santiago	2879	

ISSUE CLASSIFICATION											
ORIGINAL				CROSS REFERENCE(S)							
CLASS	SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)						
313	503			313	504	506	509				
INTERNATIONAL CLASSIFICATION				315	169.3						
H	0	5	B	33/00	428	690					
H	0	5	B	33/02							
				/							
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				/							
Mariceli Santiago 11/25/2003 (Assistant Examiner) (Date)										Total Claims Allowed: 137	
(Legal Instruments Examiner) (Date)										O.G. Print Claim(s) 1	
					(Primary Examiner) (Date)						

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant										<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original
	211		241	35	271	65	301	83	331	109	361				391
	212		242	37	272	52	302	84	332	110	362				392
	213	1	243	2	273	57	303	46	333	78	363				393
	214		244		274	62	304	49	334	101	364				394
	215	7	245	38	275	68	305	64	335	111	365				395
	216	12	246	39	276	119	306	67	336	114	366				396
	217	5	247	40	277	124	307	76	337	115	367				397
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	220	3	250	43	280	129	310	75	340	118	370				400
	221	8	251	19	281	128	311	85	341	79	371				401
	222	13	252	20	282	122	312	77	342	98	372				402
	223	17	253	21	283	130	313	86	343	108	373				403
	224	6	254	22	284	127	314	87	344	112	374				404
	225	11	255	23	285	123	315	88	345	80	375				405
	226	16	256	24	286	126	316	91	346	81	376				406
	227	4	257	25	287	131	317	92	347	82	377				407
	228	9	258	44	288	47	318	93	348	113	378				408
	229	14	259	48	289	50	319	94	349		379				409
	230	18	260	55	290	132	320	99	350		380				410
	231	26	261	60	291	133	321	96	351		381				411
	232	30	262	53	292	134	322	95	352		382				412
	233	31	263	58	293	135	323	100	353		383				413
	234	27	264	63	294	136	324	97	354		384				414
	235	34	265	51	295	137	325	102	355		385				415
	236	33	266	56	296	69	326	103	356		386				416
	237	28	267	61	297	70	327	104	357		387				417
	238	36	268	66	298	72	328	105	358		388				418
	239	32	269	54	299	73	329	106	359		389				419
	240	29	270	59	300	74	330	107	360		390				420

U.S. Patent and Trademark Office

Part of Paper No. 20031125

*Two(2) claim 72's, No claim 71. please advise.*

phosphor deposits, whereby the blue sub-pixel elements are provided by SrS:Ce and the red and green sub-pixel elements are provided by SrS:Ce and one or both of ZnS:Mn or Zn<sub>1-x</sub>Mg<sub>x</sub>S:Mn.

129 310. The EL laminate as set forth in claim 125, wherein the means for setting and equalizing the threshold voltages and for setting the relative luminosities comprises a threshold voltage adjustment layer over the red and green sub-pixel phosphor deposits.

128 311. The EL laminate as set forth in claim 125, wherein the means for setting and equalizing the threshold voltages and for setting the relative luminosities comprises the phosphor deposits being formed with different thicknesses.

122 312. The EL laminate as set forth in claim 121, wherein the means for setting and equalizing the threshold voltages and for setting the relative luminosities comprises the phosphor deposits being formed with different thicknesses.

130 313. The EL laminate as set forth in claim 129, wherein the means for setting and equalizing the threshold voltages and for setting the relative luminosities comprises the phosphor deposits being formed with different thicknesses.

127 314. The EL laminate as set forth in claim 125, wherein the means for setting and equalizing the threshold voltages and for setting the relative luminosities comprises varying the areas of one or more of the sub-pixel phosphor deposits.

123 315. The EL laminate as set forth in claim 121, wherein the means for setting and equalizing the threshold voltages and for setting the relative luminosities comprises varying the areas of one or more of the sub-pixel phosphor deposits.

126 316. The EL laminate as set forth in claim 129, wherein the means for setting and equalizing the threshold voltages and for setting the relative luminosities comprises varying the areas of one or more of the sub-pixel phosphor deposits.

131 317. The EL laminate as set forth in claim 130, wherein the means for setting and equalizing the threshold voltages and for setting the relative luminosities comprises varying the areas of one or more of the sub-pixel phosphor deposits.

41 318. The EL laminate as set forth claim 288, wherein the means for setting and equalizing the threshold voltages, and for setting the relative luminosities, comprises a threshold voltage adjustment layer selected from the group consisting of one or more of a dielectric material or a semiconductor material, which, at its deposited thickness, does not conduct until the voltage across the patterned phosphor structure exceeds the threshold voltage which the patterned